

Search Notes

Application/Control No.

10/639,462

Examiner

Benny Q. Tieu

Applicant(s)/Patent under
Reexamination

ASAMI ET AL.

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
379	142.01 142.07 142.12 142.15	9/13/2006	BQT
	88.21		
	167.07		
	167.11		
	167.13		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR